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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Wobbe et al. Art Unit : 3628
Serial No. : 10/749,808 Examiner : Unknown
Filed : December 31, 2003 Conf. No. : 5346
Title : SYSTEM AND METHOD OF MASTER DATA MANAGEMENT USING RFID
TECHNOLOGY

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

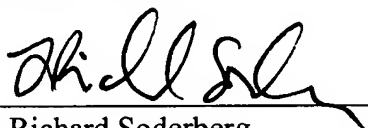
SIXTH SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office Action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

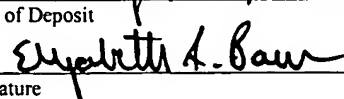
Date: 8/21/06


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Substitute Form PTO-1449
(Modified)U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
13907-065001Application No.
10/749,808**Sixth Supplemental Information Disclosure
Statement
by Applicant**
(Use several sheets if necessary)

(37 C.F.R. §1.98(b))

Applicant
Wobbe et al.Filing Date
December 31, 2003Group Art Unit
3628**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	US 6,330,598	12/11/2001	Beckwith et al.			
	AB	US 2002/0065892	05/30/2002	Malik			
	AC	US 2002/0073114	06/13/2002	Nicastro et al.			
	AD	US 2003/0018878	01/23/2003	Dorward et al.			
	AE	US 2003/0028519	02/06/2003	Burgess			
	AF	US 2003/0135495	07/17/2003	Vagnozzi			
	AG	US 2006/0064456	03/23/2006	Kalthoff et al.			

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
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Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.